

SESA6085 – Advanced Aerospace Engineering Management

Lecture 8

2024-2025



Recap



Reliability Modelling

- In our last lecture we considered the basic building blocks of reliability modelling
 - Series systems
 - Parallel systems
 - m-out-of-n systems
 - Block diagrams & block diagram decomposition
 - Common failure modes
- Today we will consider
 - m-out-of-n balanced systems
 - Active and inactive redundancy
 - Multi-state components



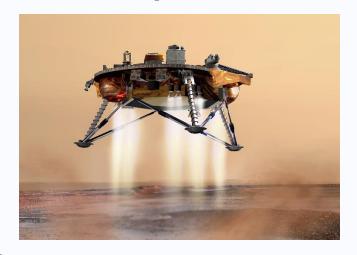


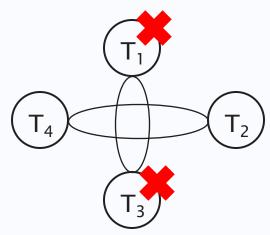
- Lets now return to our parallel m-out-of-n system
- Consider a system with n components operating in parallel
- Previously in our standard m-out-of-n redundant system if one of these components failed the others took over
- However, in some cases if one component fails another of the parallel components must be forced to shut down
- We refer to this as a m-out-of-n balanced system
 - A component must be shut down to maintain balance



m-out-of-*n* Balanced System Example

- A mars lander has a series of thrusters used to slow its descent
- If one of these thrusters fails then the opposite thruster should be disabled so as to maintain the balance of the vehicle
- In our 4 thruster example, if T1 fails
- Then T3 should be shut down







- Let's assume that all components in such a system are identical and function with probability p
- Let's define the status of the i^{th} engine as X_i where,

$$X_i = \begin{cases} 1 & \text{if the ith engine functions} \\ 0 & \text{if the ith engine fails} \end{cases}$$

Hence,

$$P(X_i = 1) = p$$
$$P(X_i = 0) = 1 - p$$



Let's also define Y,

$$Y = \begin{cases} 1 & \text{the system operates successfully} \\ 0 & \text{the system fails} \end{cases}$$

- Finally let's define the successful operation of a pair of components as $X^{(i)}$
- The success of a pair of components is given by,

$$P(X^{(i)} = 1) = p^2$$

Therefore the failure of a pair of components is,

$$P(X^{(i)} = 0) = 1 - p^2$$



System unreliability occurs when n component pairs fail

$$P(Y = 0) = \prod_{i=1}^{n} P(X^{(i)} = 0)$$

The reliability of the system is then

$$R = 1 - P(Y = 0) = 1 - \prod_{i=1}^{n} P(X^{(i)} = 0)$$



m-out-of-*n* Balanced System Example

- Let's revisit our descent thruster system
- We have 4 thrusters which are paired together, p=0.95
- Calculate the reliability of a 2-out-of-4 balanced system
- From our previous equation

$$R = 1 - (1 - p^2)^2$$
$$R = 0.9905$$

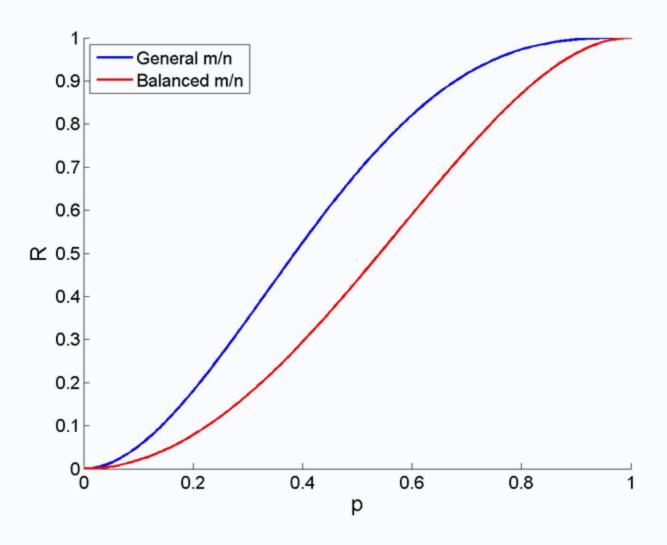


- Is a balanced m-out-of-n system more reliable than our basic m-out-of-n redundant system?
- The reliability for our 2-out-of-4 redundant system is:

$$R = 6p^2 - 8p^3 + 3p^4$$
$$R = 0.9995$$

• A balanced redundant system is never as reliable as a standard redundant system except when p=1.0





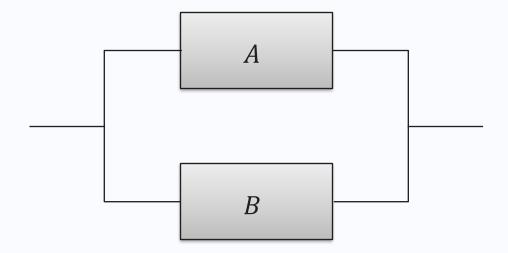


Active & Inactive Redundancy



Redundancy

Recall our traditional parallel redundant system



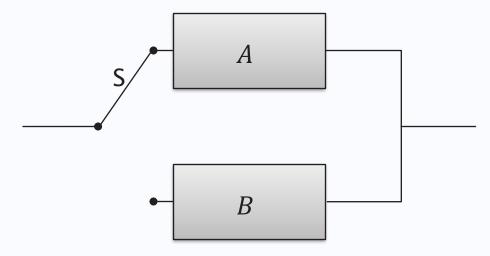
• Is such a system completely realistic?



Active & Inactive Redundancy

- Our classic parallel redundant system is an example of an active redundant system
- In such a system all of the components are active and sharing the load
- An inactive redundant system is one whereby other component(s) start operating when the main component fails

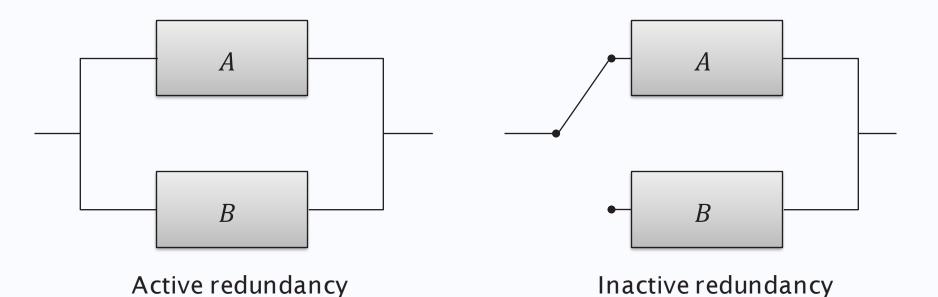




- Above is an RBD representation of such a system including a switch, denoted S
- There is no difference between an active and inactive redundant system if the switch is perfect and all components have the same failure rate



 Let's assume we have a system with two components in parallel, in one configuration the components are in an active redundant arrangement and in the other they are in a inactive redundant arrangement





For the active redundant configuration:

$$R_{\text{active}} = 1 - P(\bar{A}\bar{B}) = 1 - P(\bar{A})P(\bar{B}|\bar{A})$$

 Which we've seen previously, given each component's reliability is p:

$$R_{\text{active}} = 2p - p^2$$

For the inactive redundant configuration:

$$R_{\text{inactive}} = 1 - P(\bar{A}\bar{B}) = 1 - P(\bar{A})P(\bar{B}|\bar{A})$$

The formulae appear to be the same, but are they?



- Why are they different?
- The key difference is in the term $P(\bar{B}|\bar{A})$
- For an active redundant system this reduces to $P(\overline{B})$ as a failure in component A is independent from B and is assumed to have been operating since t=0
- For an inactive redundant system $P(\bar{B}|\bar{A})$ is always a dependent probability as B does not start until A fails
 - $-P(\bar{B}|\bar{A})$ is therefore a function of time



Standby Definitions

- Before proceeding lets define the different types of standby systems:
- Hot standby:
 - Standby components have the same failure rate as the primary component
- Warm standby:
 - Standby components have a smaller failure rate than the primary component but greater than zero
- Cold standby:
 - Standby components don't fail in standby and have a zero failure rate until activated



Standby Definitions

- If the primary component has a failure rate of λ
- Then:
 - $-\lambda_{hot} = \lambda$
 - $-\lambda_{cold}=0$
 - $-\lambda_{\text{warm}} < \lambda$



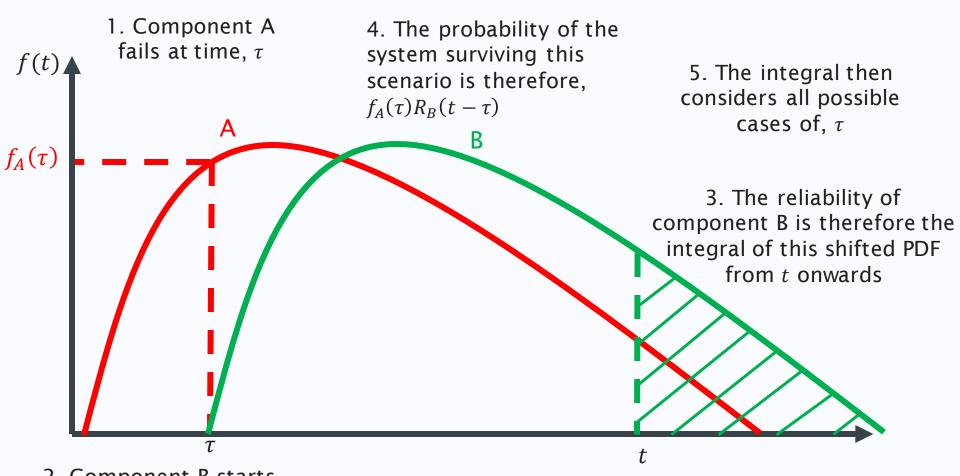
A Simple Standby System

- Let's take a simple standby system defined by 2 components
- Then the reliability of the system at a time, t, is equal to the reliability of unit A until t and the probability that A fails at a time, τ , $0 < \tau < t$ and the standby unit functions successfully from τ to t

$$R_{Sb}(t) = R_A(t) + \int_{\tau=0}^t f_A(\tau) R_B(t-\tau) d\tau$$



A Graphical Interpretation



2. Component B starts working at time, τ , it's PDF is therefore shifted by τ



A Simple Standby System

If we assume the PDFs of both components are defined by an exponential i.e.

$$f(t) = \lambda e^{-\lambda t}$$
$$R(t) = e^{-\lambda t}$$

• And their respective hazard rates are $\lambda_A \& \lambda_B$ then:

$$R_{sb}(t) = e^{-\lambda_A t} + \int_{\tau=0}^{t} \lambda_A e^{-\lambda_A \tau} e^{-\lambda_B (t-\tau)} d\tau$$



A Simple Standby System

Which equates to:

$$R_{sb}(t) = e^{-\lambda_A t} + \frac{\lambda_A e^{-\lambda_B t}}{\lambda_A - \lambda_B} \left(1 - e^{-(\lambda_A - \lambda_B)t} \right)$$

• Or if the components are identical $\lambda_A = \lambda_B$:

$$R_{sb}(t) = (1 + \lambda t)e^{-\lambda t}$$



Multi-unit Standby Systems

- Let's extend the system to include n components with n-1 in standby
- In such a system if component one fails, component two takes over, when this unit fails component three takes over...
- In such a case, with identical failure rates the reliability is:

$$R_{sb}(t) = e^{-\lambda t} \left[1 + \lambda t + \frac{(\lambda t)^2}{2!} + \dots + \frac{(\lambda t)^{n-1}}{(n-1)!} \right]$$



Standby System Example

- A system consists of two components with constant hazard rate, $\lambda = 0.5 \times 10^{-6}$
- These components can be in either an active or inactive redundant system
- Compare the reliabilities of each system, which is more reliable?



Standby System Example

• The reliability of the parallel system is:

$$R_p(t) = 1 - (1 - e^{-\lambda t})^2$$

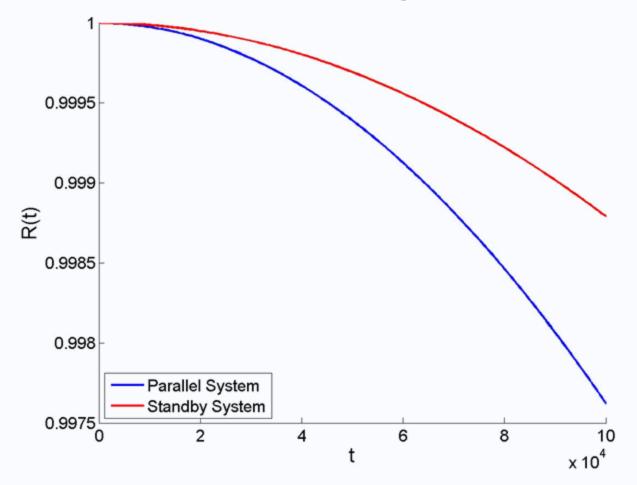
 Using our previous equation, the reliability of the standby system is:

$$R_{sb}(t) = e^{-\lambda t} [1 + \lambda t]$$



Standby System Example

Clearly the standby system offers greater reliability





Multistate Components



Multistate Components

- Until now we've only considered components which can be in either one of two states – working or failed
- However, there can be instances where a component can fail in more than one mode
- Such systems are called multistate systems
- They are special in that adding additional components may increase or reduce the reliability of the system depending on the dominant failure mode



Multistate Components

- Consider a diode in an electronic system
- A diode allows current in one direction but not in another
- The resistance is therefore zero forward but infinite in reverse
- Diode can therefore have three states:
 - 1. Operate normally
 - Fail due to an infinite resistance in both directions (an open circuit)
 - Fail due to a zero resistance in both directions (a short circuit)





Multistate Series System

- Let's consider a system defined by n diodes in series
- For each diode we have three states:
 - x
 Component works correctly
 - $-\bar{x}_s$ Fails due to a short circuit
 - $-\bar{x}_o$ Fails due to an open circuit
- When in series:
 - The whole system fails if any component is \bar{x}_o
 - The whole system fails if all components are \(\bar{x}_s\)



Multistate Series System

For the case with one component (n=1), the reliability is:

$$R = P(x) = 1 - P(\bar{x}_s) - P(\bar{x}_o)$$

For a two component system (n=2), the reliability is:

$$R = 1 - P(\bar{x}_{o1} + \bar{x}_{o2} + \bar{x}_{s1}\bar{x}_{s2})$$

$$R = 1 - [P(\bar{x}_{o1}) + P(\bar{x}_{o2}) - P(\bar{x}_{o1}\bar{x}_{o2}) + P(\bar{x}_{s1}\bar{x}_{s2})]$$

• Defining the probabilities of failures as q_o and q_s we obtain the general expression:

$$R = \prod_{i=1}^{n} (1 - q_{oi}) - \prod_{i=1}^{n} q_{si}$$



Multistate Series System

- Unlike a standard series system the reliability of a multistate system will reach a maximum for an optimum number of components
- Derivatives of the above expression can be taken to calculate an optimum number of components
- A number of components greater than or less than this value will result in a suboptimal system reliability
- N.B. the presented formulae may change if the failure modes of the entire system alter



Multistate Parallel System

 Using our previous notation, the reliability for a system with two components in parallel is:

$$R = 1 - P(\bar{x}_{o1}\bar{x}_{o2} + \bar{x}_{s1} + \bar{x}_{s2})$$

$$R = 1 - [P(\bar{x}_{o1})P(\bar{x}_{o2}) + P(\bar{x}_{s1}) + P(\bar{x}_{s2}) - P(\bar{x}_{s1})P(\bar{x}_{s2})]$$

$$R = 1 - [q_{o1}q_{o2} + q_{s1} + q_{s2} - q_{s1}q_{s2}]$$

Or for n components in parallel:

$$R = \prod_{i=1}^{n} (1 - q_{si}) - \prod_{i=1}^{n} q_{oi}$$



Multistate Parallel System

- If all components are identical then the optimum number of components for maximum reliability is 1 if $q_{\rm S}>q_{\rm o}$
- As with the series system derivatives can be taken with respect to n to calculate an optimal number of components
- N.B. Once again the above formula holds for the failures of a diode and similar cases but may need to be derived again for other cases

